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Reduced electron relaxation time of perovskite films via g-C₃N₄ quantum dot doping for high-performance perovskite solar cells†

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Perovskite film-quality is a crucial factor to improve the photovoltaic properties of perovskite solar cells, which is closely related to the morphology of crystallization grain size of the perovskite layer. However, defects and trap sites are inevitably generated on the surface and at the grain boundaries of the perovskite layer. Here, we report a convenient method for preparing dense and uniform perovskite films, employing g-C₃N₄ quantum dots doped into the perovskite layer by regulating proper proportions. This process produces perovskite films with dense microstructures and flat surfaces. As a result, the higher fill factor (0.78) and a power conversion efficiency of 20.02% are obtained by the defect passivation of g-C₃N₄QDs.

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Introduction

Organic-inorganic hybrid perovskite solar cells (PSCs) have attracted intensive attention in the last few years due to outstanding photoelectric properties of perovskite semiconductor materials such as longer exciton diffusion length, higher absorption coefficient and easier tunable direct bandgap,^{1–3} which have promoted high power conversion efficiencies (PCEs) of PSCs to the current world record of 25.7% (ref. 4) based on a single junction device. Particularly, the perovskite light-absorbing layer attracts much attention by its simple and low-temperature fabrication technology.^{5–8} The crystal quality, surface morphology and grain size^{9,10} of a perovskite active layer is the key point for high-performance PSCs.^{11–13} There are many ways to optimize the crystalline process of a perovskite layer such as solution engineering,¹⁴ ion doping¹⁵ *etc.*, which controls the crystallization of perovskite film by modifying nucleation and growing-process are important measures toward achieving high quality perovskite films.^{16,17} Nevertheless, the relationship between perovskite crystal dynamics and film properties has not been thoroughly studied so far, especially the relationship between the electronic relaxation time of perovskite layer and device properties is also rarely studied.

As the light-absorbing layer of PSCs, perovskite layer plays a significantly important role in the performance of devices. Several works have been published to highlight the contribution

of central structure to the performance of PSCs. It is very effective to optimize central structure of devices by using doped semiconductor and nanometer material into the perovskite layer and transport layer.^{18–20} As examples, Liao group²¹ achieved a PCE of 19.49% by doping a 2D polymeric material of graphitic carbon nitride (g-C₃N₄) into the perovskite layer to reduce its intrinsic defect density. Wu *et al.*²² utilized the synergistic effect of H₂O and DMF preparing a high-quality and large-area perovskite film, which realized a high PCE of 20.1%. Chen *et al.*²³ demonstrated the planar heterojunction solar cells with a PCE of 18.4% improved from 16.0% by presenting the Ag incorporated organic-inorganic perovskite films. Nucleation and crystal growth are the key factors in the controllable morphology of solution processed perovskite film.^{24–26} In general, the growth of perovskite layer is dependent on precursor composition, solvent choice, deposition temperature and time, and so on, which is regarded as the fascinating role to improve the optoelectronic properties of PSCs.^{27,28} Especially, solvent engineering plays very effective role in the controllable growth of solution-processed crystalline films. Moreover, due to the perovskite crystalline nature, the perovskite interfaces also influence the device performance.²⁹ In addition, less grain boundaries and thickness of perovskite layer are all also key elements contribute to high-efficiency PSCs.^{30–34} Large grains can improve the perovskite film morphology and coverage effectively to reach an enhanced light-harvesting under unified light intensity.^{35–39}

The studies of quantum dots modified PSCs mainly focused on the application of carbon quantum dots (CQDs) in devices, and the application of g-C₃N₄QDs in PSCs is rarely reported. Huang group⁴⁰ have introduced CQDs with hydroxyl and carbonyl groups on the surface into perovskite precursor solutions, where the functional groups interact with lead ions to

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form an intermediate phase, effectively reducing non-radiative recombination and preparing efficient and stable solar cells. Compared to CQDs, g-CNQDs have abundant functional groups on their surface, which promotes the forming of intermediate phases in perovskite precursor solutions. By adjusting the concentration, the nucleation sites during the perovskite crystallization process can be controlled, thereby optimizing the quality of perovskite thin films.

The graphene-like material was synthesized by hydrothermal method, and then its quantum dots were prepared by ultrasonic stripping. Herein, we fabricate the high-performance PSCs based on perovskite light-absorbing layer doped with Quantum Dots (QDs). The suitable doping of QDs increases perovskite crystallization grain size by hydroxylamine and carboxyl groups, which reduces intrinsic defect density by passivating the charge recombination centers around the grain boundaries. Moreover, the electronic relaxation time is reduced and the current density of the device is effectively improved. This results in a champion solar cell with a PCE of 20.07% with a short-circuit current density (J_{sc}) of 25.93 mA cm⁻², and a fill factor (FF) of 0.78.

Experiment

Perovskite precursor solution

The precursor solution was prepared by dissolving FAI : PbI₂ : MABr : PbBr₂ : CsI in 1 mL coalescing solvents of dimethyl sulfoxide : 1,4-butyrolactone (DMF:DMSO) 4 : 1 (v/v) to make perovskite solution. The amounts of components are 237.7 mg, 690.9 mg, 4.78 mg, 16.51 mg and 19.39 mg, respectively. First, the g-C₃N₄ was prepared by Hydrothermal Synthesis based on nitrogen-rich organic compounds such as thiourea and urea under 500 °C high-temperature calcination conditions for 3 h with a ramp rate of 5 °C min⁻¹, then the g-C₃N₄ nanosheets was oxidized in H₂SO₄ (10 mL)/HNO₃ (30 mL) mixture for 12 h under mild ultrasonication (500 W, 40 kHz). The g-C₃N₄ precursor was exfoliated by liquid-phase assisted method in organic polar solution (DMF/5 mL) to obtain the ultrathin g-C₃N₄ main material. Last, g-C₃N₄QDs were carefully prepared by ultrasonic peeling (300 W, 20 kHz) through a 0.22 μm microporous membrane. The Fig. S5† shows the TEM images of g-C₃N₄ nanosheets and g-C₃N₄QDs, the diameters of as-prepared g-C₃N₄QDs are in the range of 5–8 nm (5.6 nm average diameter). The g-C₃N₄QDs dissolves in the perovskite precursor solution according to the proportion of 0.2 wt%/0.4 wt%/0.6 wt%/0.8 wt%. g-C₃N₄QDs solution was prepared by dissolving with 50 mg in 1 mL DMF, the proportions correspond to 20 μL/30 μL/40 μL/50 μL as shown in Fig. 1.

Devices and characteristics

Perovskite solar cell preparation

The perovskite layers and charge transporting layers are prepared in nitrogen-filled glovebox by spin coating. The perovskite light-absorbing layer is fabricated by a one-step, anti-solvent method, which involves chlorobenzene as the anti-solvent to induce crystallization. The FTO usually used as substrates cathode of PSCs, which is dealt successively with

ultrapure water, acetone (two times), ethanol (two times) in ultrasonic cleaner. The poly(3,4-ethylene dioxythiophene):poly(4-styrenesulfonate) (PEDOT:PSS) layer is prepared by spin coating method. The perovskite precursor solution is deposited on PEDOT:PSS/FTO substrates by program which includes two steps, first at 2000 rpm for 20 s and then 4000 rpm for 40 s. Chlorobenzene is dropped onto the substrates during the second step after 20 seconds. Then the perovskite film is annealed at 100 °C for 10 min on a hot plate in the glovebox. The ETL (PCBM) solution (20 mg in 1 mL Chlorobenzene) is deposited on the top of perovskite layer at 4000 rpm for 40 s.

Characteristics

The absorbance of the perovskite films on PEDOT:PSS/FTO was measured with a UV/vis spectrophotometer (PerkinElmer Lambda 750). Scanning electron microscopy (SEM) images were measured by a field emission scanning electron microscope (Hitachi SU8010). X-ray diffraction (XRD) patterns of the perovskite films coated on the PEDOT:PSS are performed by a PANalytical 80 equipment (Empyrean, Cu Ka radiation). Electrochemical impedance spectroscopy (EIS) is investigated using an IM6e Electrochemical Workstation (ZAHNER, Germany) with an alternating current amplitude of 10 mV in the frequency range of 100 kHz to 0.01 kHz, and the equivalent electrical circuit was fitted using the impedance data. The test was completed in the dark. X-Ray photoelectron spectroscopy (XPS) curves are measured under an ultrahigh vacuum by a Thermo Fisher ESCALAB 250Xi instrument with a monochromatic Al K Alpha (1486.68 eV) X-ray source. The measurement is calibrated using the C 1 s carbon peak (284.8 eV) under CAE mode with step size of 0.05 eV. Ultraviolet photoelectron spectroscopy (UPS) measurements are used the same model as XPS with the He radiation ($h\nu = 21.22$ eV) source under an ultrahigh vacuum of 1×10^{-8} mbar. The steady state photoluminescence (PL) spectra of the perovskite films on FTO substrates are collected using Horiba Jobin-Yvon LabRAM HR800 with a 480 nm excitation wavelength. Room temperature Hall-effect measurements are performed with a Lake Shore Model 8404 Hall-Effect Measurement System with DC and AC magnetic fields of ± 1.7 T (DC) and ~ 1.2 T RMS (AC, 100 mHz), respectively. Hall mobility is extracted from the measured Hall voltage and the measured 4-point resistivity for the particular excitation current and magnetic field applied (Hall factor set to unity). Sheet carrier concentration is extracted likewise from the Hall voltage. The J - V curves, including the reverse and forward scans were measured (2400 Series Source Meter, Keithley Instruments) under simulated Air-Mass (AM) 1.5 sunlight at 100 mW cm⁻² (Newport, Class AAA solar simulator, 94023A-U) with the scanning rate of 20 mV s⁻¹ and tested in nitrogen-filled glovebox.

Results and discussion

Fig. 1a shows the device configuration of the planar PSCs (FTO/PEDOT:PSS/perovskite/PCBM/BCP/Ag). PSCs bases on ABX₃



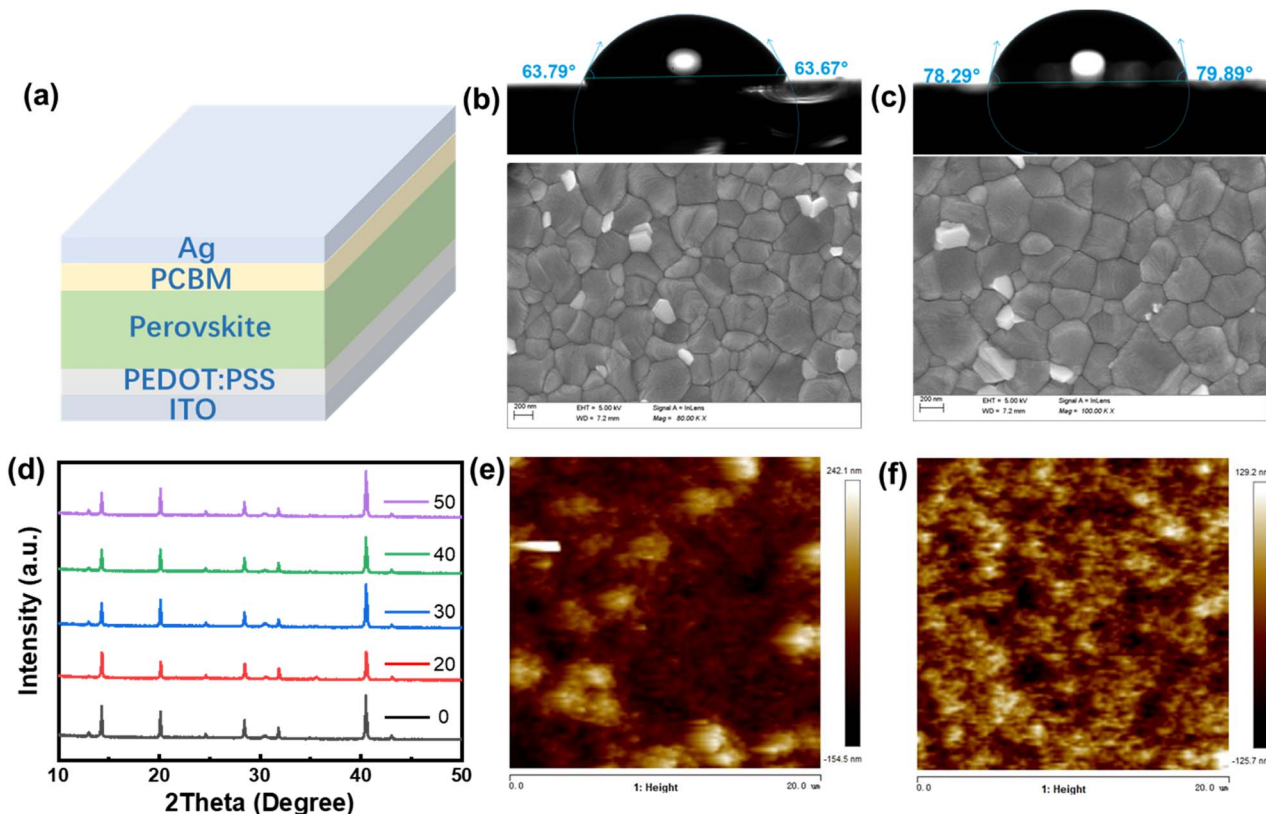


Fig. 1 (a) Device architecture (b and c) the contact angle testing and surface-view SEM images of perovskite films without and with the optimized concentration of additive (30). (d) XRD patterns of perovskite films with different doping ratios of g-C₃N₄QDs films deposited on PEDOT:PSS/FTO. The 20/30/40/50 corresponding to the 0.2 wt%/0.4 wt%/0.6 wt%/0.8 wt%, respectively. (e and f) AFM images of perovskite films without and with the optimized concentration of additive (30).

(where A is MA⁺ and FA⁺, B is Pb²⁺ and Cs²⁺, X is Br⁻ and I⁻) have become the most promising power source of all the solar cells because of their low manufacture cost, high open-circuit voltage (V_{oc}) and excellent PCE. Fig. 1b and c show the top-view images of perovskite films without and with g-C₃N₄QDs deposited on PEDOT:PSS layer coated on FTO glass by using scanning electron microscopy (SEM) respectively. The increased interfacial contact angle shows highly hydrophobic of perovskite film with g-C₃N₄QDs, which created by the ordering growth of perovskite grains based on the introduction of g-C₃N₄QDs. Fig. 1c shows the size of perovskite cuboids increases with doping g-C₃N₄QDs and the morphology shows almost full surface coverage with larger grains in comparison with the control sample. Notably, both films with different doping ratios of g-C₃N₄QDs have denser and better uniform morphology (Fig. S1a–e†). The decreases of pinholes avoid the direct contact between PEDOT:PSS and PCBM, which suppress the electrons recombined with the holes. Fig. 1d shows the XRD of perovskite films based on g-C₃N₄QDs. It is obvious that the films fabricated from perovskite solutions in the absence and presence of g-C₃N₄QDs have a cubic perovskite phase with an almost unchanged crystal structure. The main peaks around 13.99° and 28.36° are corresponding to the (110) and (200) crystal plans, which confirms the perovskite structure of the as-prepared films has no difference. The morphology of perovskite films is

associated with the crystallinity, the crystallization peak strength of films with g-C₃N₄QDs increased. Fig. 1d shows the similar crystal structure exhibit in these films, however, the difference is obvious in consideration of surface coverage and film conformity, which are well known to be the most significant parameters that affect device performance. Fig. 1e and f shows the AFM images of perovskite films with and without g-C₃N₄QDs incorporation. Compared to the pristine perovskite film, obviously improvement in film morphology was observed in g-C₃N₄QDs modified perovskite films. The root-mean-square value of perovskite film was determined to be 44.1 nm. It decreased to 29.3 nm after incorporating g-C₃N₄QDs (30%). The influence of other doping ratios on the surface morphology were shown in Fig. S1f–j,† respectively. The reduced roughness suggests a good interfacial contact between the perovskite layer and the upper electron-transporting layer.

Fig. 2a displays the UV-Vis spectra of the perovskite layer doped with g-C₃N₄QDs. There is no large difference in the absorption wavelength range of the perovskite films in visible light range, however, the absorption of all peaks of the film with g-C₃N₄QDs enhanced among 400–550 nm. The bandgap of perovskite films with and without the g-C₃N₄QDs films are extrapolated from the optical absorption spectra as shown inside, which has no difference with the g-C₃N₄QDs employment. The band gaps of the perovskite films with and without



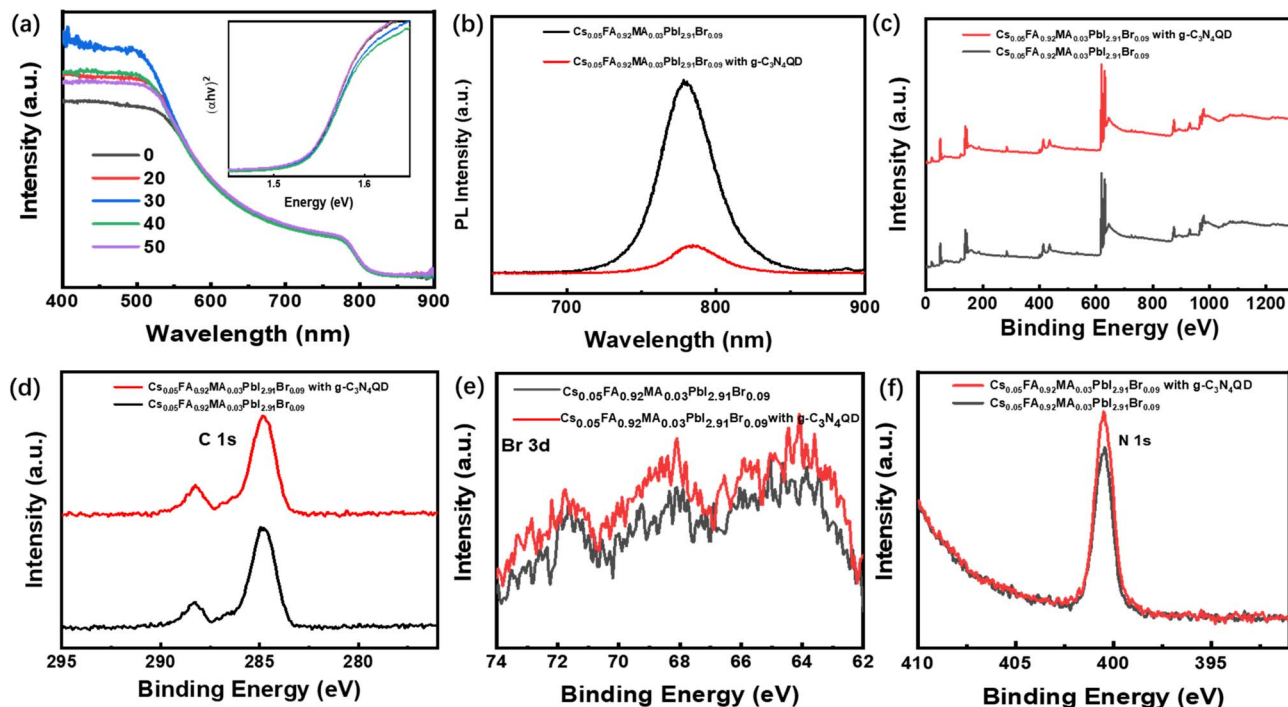


Fig. 2 (a) The absorption spectrum of perovskite films without and with the optimized concentration of additive (30). (b) The steady-state photoluminescence spectrum of perovskite films without and with the optimized concentration of additive (30) deposited on the PEDOT:PSS/FTO. (c) The XPS spectra of perovskite films without and with the optimized concentration of additive (30). (d–f) High-resolution XPS C 1s/Br 3d/N 1s spectra of perovskite films without and with the optimized concentration of additive (30).

the $g\text{-C}_3\text{N}_4\text{QDs}$ can be extrapolate from the Tauc plot ($(\alpha h\nu)^{1/2}$ vs. eV). Fig. 2b shows the steady-state photoluminescence (PL) measurements to explore the recombination behaviors of photogenerated carriers in perovskite films with and without $g\text{-C}_3\text{N}_4\text{QDs}$. The normalized PL intensity increases with the doping of $g\text{-C}_3\text{N}_4\text{QDs}$, exhibiting the same tendency as the SEM results. This signifies that an appropriate amount of $g\text{-C}_3\text{N}_4\text{QDs}$ can render perovskite films with reduced levels of nonradiative charge carrier recombination. The increased grain size and PL intensity of perovskite film show $g\text{-C}_3\text{N}_4\text{QDs}$ can passivate the negative defects in the polycrystalline perovskite films. As a result, we believe that the proper amount of $g\text{-C}_3\text{N}_4\text{QDs}$ addition is beneficial to obtain perovskites with favorable grains and lower trap densities, and the crystallinity increased obviously to some extent, the suppression of charge carrier recombination and reduced number of defect sites grant positive effects to enhance device performance. To investigate the influence of $g\text{-C}_3\text{N}_4\text{QDs}$ on the electronic structure of perovskite film, X-ray photoemission spectroscopy (XPS) was employed to analyze the core levels of C/N/Br elements. As shown in Fig. 2c–f, the XPS survey spectrum of $g\text{-C}_3\text{N}_4\text{QDs}$ clearly presented three peaks with different binding energy of 287.2 and 398.2 eV, corresponding to the core level of C 1s and N 1s, respectively. It is obviously that the binding energy of C, N elements have no changed, the hydroxylamine and carboxyl groups in $g\text{-C}_3\text{N}_4\text{QDs}$ made the stronger element content of the corresponding elements. However, obvious change of Br 1s was observed after introducing $g\text{-C}_3\text{N}_4\text{QDs}$ into the perovskite film. In addition, the

bromine line (Br 3d) was also detected by the high energy resolution of XPS. To better understand the influence of $g\text{-C}_3\text{N}_4\text{QDs}$ doping on the Br 3d core level, the deconvolutions of Br 3d spectra in the perovskite film was executed as shown in Fig. 2f. The Br 3d line can be resolved into two contributions, the Br $3d_{3/2}$ peak centered at 68.40 eV and Br $3d_{5/2}$ peak centered at 71.75 eV, implying the ionic state of Br in the sample. In addition, a shift was observed in the binding energies of the chemical states of Br 3d in the $g\text{-C}_3\text{N}_4\text{QDs}$ modified perovskite film. The shift toward lower binding energy caused by the reduction property of hydroxylamine group in the $g\text{-C}_3\text{N}_4\text{QDs}$. The low binding energy indicates the $g\text{-C}_3\text{N}_4\text{QDs}$ provides charge to the perovskite, which show higher relaxation energy contributed to electron kinetic energy. The high electron kinetic energy helps to improve the charge mobility.

Furthermore, ultrafast transient absorption (TA) spectroscopy was employed to study the in-depth charge transfer dynamics in the perovskite films. By tracking the bleach recovery of the corresponding transitions, we can characterize the recombination of photogenerated carriers in perovskite films. As shown in Fig. 3a and b, a broad negative absorption feature peaking at 740 nm is observed in both perovskite film and doped $g\text{-C}_3\text{N}_4\text{QDs}$, nanowires, which is derived from the photogenerated electrons in perovskite film. The much stronger negative absorption of $g\text{-C}_3\text{N}_4\text{QDs}$ (30%) engineered perovskite film suggests a higher concentration of photogenerated electrons. A transient absorption peak located at 740 nm is observed for both control and engineered perovskite film, indicating that



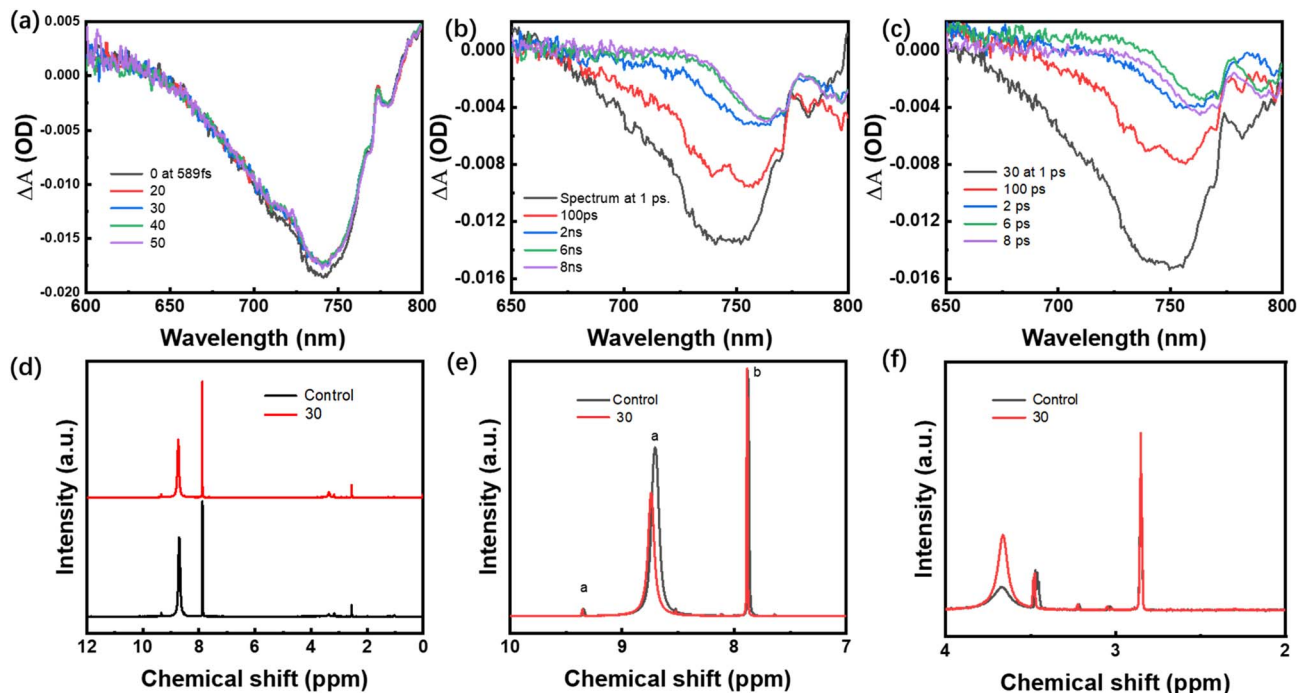


Fig. 3 (a) TA spectra of perovskite films with different g-C₃N₄QDs doping ratios at 589 fs Normalized kinetic traces after excitation at 460 nm. (b and c) TA spectra of perovskite films without and with the optimized concentration of additive (30) at 1 ps. (d) Liquid-state ¹H magnetic resonance (NMR) spectra of (a) perovskite precursor solutions with and without g-C₃N₄QDs (DMF) in deuterated *N,N*-dimethylformamide-*d*₇ (DMF-*d*₇) and (e) magnification of the scale between 7 and 10 ppm. (f) 2–4 ppm.

the two films can be excited by NIR light. Besides, the transient absorption intensity at 740 nm decreases from 1 ps to 8 ns *via* recombination with multiple time constants. The faster decline of charge concentration in engineered perovskite film compared to control film reveals that the electron decay process can be slowed in engineered perovskite film. Moreover, the explicit expression for the electron decay kinetics at 740 nm is calculated in detail. Fig. 3c shows transient fluorescence spectrum exported from TA curves, the fitted time profiles exhibit the delay time of engineered perovskite film (1274.93 ps) longer than that for control film (828.38 ps). Accordingly, the above results confirm that the introduction of g-C₃N₄QDs doping are favorable for the prolonged lifetime of photogenerated electrons. To uncover the effect of g-C₃N₄QDs on the electronic structures of perovskite, the Nuclear Magnetic Resonance (NMR) of ¹H was carried out. Fig. 3d shows the ¹H-NMR of perovskite films without and with g-C₃N₄QDs. The DMSO-*d*₆ used as liquid-state NMR solvent can avoid the influence of ¹H-NMR signals of solvent on the samples. The peaks originated from the solvent were marked in the figure. Fig. 3e shows a magnification of the scale between 7 and 10 ppm. The broad peak at (a) belongs to protons of the FA amine groups, (b) belongs to CH of FA. A downshift (larger chemical shift) was clearly reflected at point (a) and (b) under the condition of g-C₃N₄QDs modified, which attributed to the inductive effect of hydroxylammonium groups in g-C₃N₄QDs causes electron density of FA in perovskite precursor solution to change. The downshift reflects a lower electron density induced by electron-attracting groups in the FA amine groups, which suppressed the

electron energy loss and nucleate pace in the perovskite crystallization process. The broad peak between 2 and 4 ppm belongs to MA of perovskite, the same downshift also reflects the g-C₃N₄QDs induction as shown in Fig. 3f.

The current density–voltage (*J*–*V*) characteristics of the fabricated PSCs are carried out under simulated AM 1.5 sunlight conditions, as shown in Fig. 4a. The device based on g-C₃N₄QDs (30) shows a high PCE of 20.02%, with a *J*_{sc} of 25.93 mA cm⁻², a *V*_{oc} of 0.99 V, a FF of 0.78, and the PSC without the presence of g-C₃N₄QDs shows a PCE of 17.19%, with a *J*_{sc} of 23.95 mA cm⁻², a *V*_{oc} of 0.97 V, a FF of 0.74 (Table 1). Further increasing the g-C₃N₄QDs content deteriorates the device performance due to the reduced *J*_{sc} and FF. The increased *J*_{sc} benefitted from reduced surface defects and enlarged grains, which indicates that a compact interface contact is assumed to be formed between perovskite layer and ETL This fact is favorable for the suppression of shunting paths in the device and benefits the electron extraction, resulting in an enhanced FF. The increase in FF is primarily ascribed to the reduction of surface recombination and the enhancement of the charge collection efficiency. Fig. 4b shows the external quantum efficiency (EQE) of the reference and doped with g-C₃N₄QDs PSCs. It can be observed that EQE is improved all over the spectra from 300 to 850 nm in the g-C₃N₄QDs based PSCs. The integrated *J*_{sc} from the EQE spectra is around 24.51 mA cm⁻² of PSC with g-C₃N₄QDs (30 μl), close to the *J*_{sc} obtain from the *J*–*V* sweep measurement, confirming the accuracy of device efficiency characterizations. To test the effect of g-C₃N₄QDs (30) on the device stability, Fig. 4S† shows the PCE decay trend of

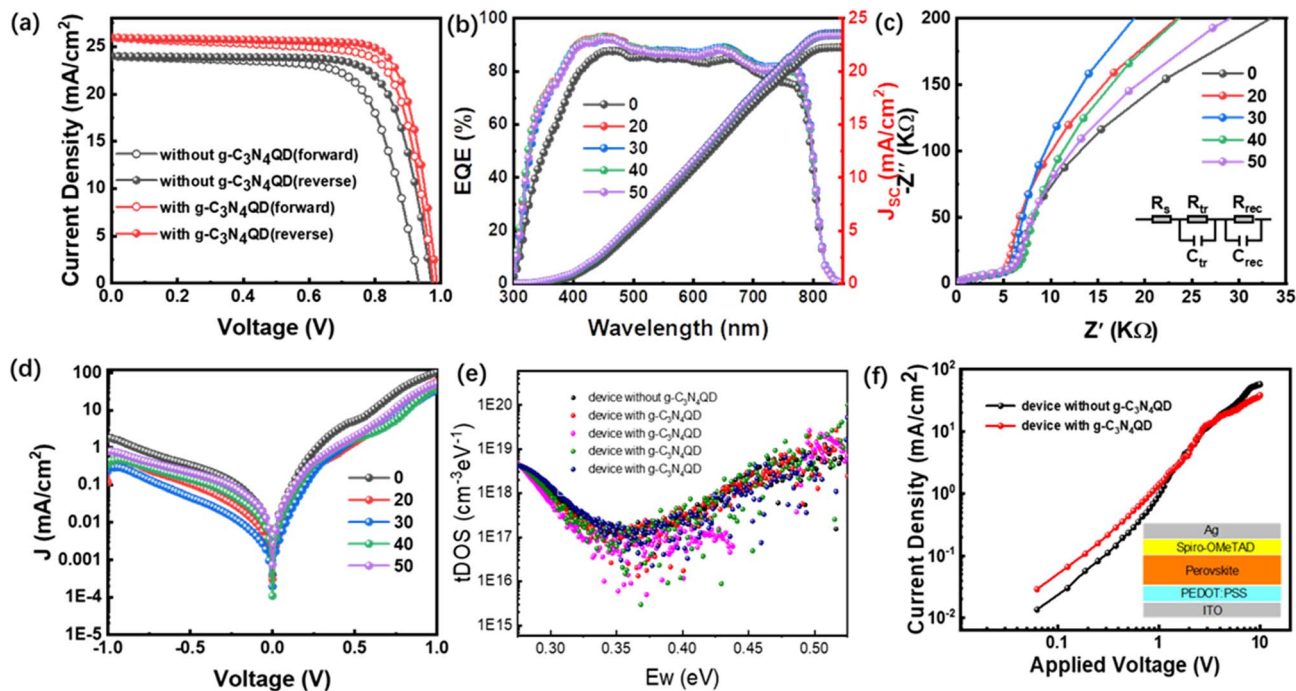


Fig. 4 (a) J - V curves of the devices without and with the optimized concentration of additive (30). (b) EQE spectra and their integrated current densities. (c) OCVD curves of the PSCs without and with the optimized concentration of additive (30). (d) Dark current-voltage curves of devices with different doping ratios. (e) Evolution of trap density during devices with different doping ratios. (f) Hole-only devices without and with the optimized concentration of additive (30) with the structure shown in the inset.

contrastive experiment devices with RH = 30%. The device with g-C₃N₄QDs (30) shows the slow decay compared to the control device under uninterrupted 120 hours testing process. The improved PCE stability in device with g-C₃N₄QDs (30) is considered of benefits from suppressed surface recombination and higher charge collection efficiency.

We ascribed it to a passivation effect of g-C₃N₄QDs with flat perovskite surface and good interface contact with upper layer component. Electrochemical impedance spectrum (EIS) is an effective method to provide rich interfacial information such as contact resistance in multilayer devices. Fig. 4c gives the Nyquist plots of both devices in the dark at an applied voltage of 0.95 V. The series resistance (R_s), transport resistance (R_{tr}) and composite resistance (R_{rec}) could be extrapolated by employing an equivalent circuit model composing of R_s , R_{tr} , R_{rec} and parallel capacitor C . The Nyquist plots have two round arcs of devices without and with g-C₃N₄QDs. The modified device has a reduced radius of the first round arc at high frequency, which demonstrates that g-C₃N₄QDs doping reduced the carrier

transfer resistance and optimized the contact interface. There are pretty clear differences between the second round arc at low frequency. The increased radius demonstrates that g-C₃N₄QDs doping enlarged the carriers composite resistance, which means lower carriers recombination loss. Fig. 4d shows the (J - V) characteristics in the dark of devices without and with g-C₃N₄QDs in different proportions. The higher dark current density indicates more carriers in the region has been consumed by defects in the perovskite film and device. The lower dark current density indicates g-C₃N₄QDs-passivation decreased the scattering centers of the carriers at the grain boundaries, thus, increased the Hall mobility of the carriers. The shift up of dark current density induced by more carriers recombination with the increase of g-C₃N₄QDs doping density. To explore the formation of defects influence on the performance of the solar cells, we conducted defect density measurement to understand what caused the degradation of devices under dark illumination. Fig. 4e shows trap energy level and the energetic profile of trap density of states (tDOS) of PSCs. It was found that g-C₃N₄QDs

Table 1 The cell performance of perovskite solar cells based on g-C₃N₄QDs additive

Devices	V_{oc} (V)	J_{sc} (mA cm ⁻²)	FF (%)	PCE (%)
Perovskite	0.97	23.95	0.74	17.19
Perovskite-g-C ₃ N ₄ QDs (0.2 wt%)	0.98	25.04	0.76	18.64
Perovskite-g-C ₃ N ₄ QDs (0.4 wt%)	0.99	25.93	0.78	20.02
Perovskite-g-C ₃ N ₄ QDs (0.6 wt%)	1.00	24.81	0.76	19.08
Perovskite-g-C ₃ N ₄ QDs (0.8 wt%)	1.00	24.62	0.72	17.62



caused a reduced trap density with energy depth of 0.25 to 0.45 eV, where the charge traps are caused by the recombination of carriers in perovskites. The reduction of deep traps can be explained by the reduction of amorphous regions during annealing, which benefits from the forming of passivation interface doped with g-C₃N₄QDs. It is consistent with morphology study in terms of increased grain size during annealing.

To confirm the effect of g-C₃N₄QDs additive to the charge transporting of PSCs, the space charge limited current (SCLC) region can reflect the efficient charge transfer of device. Fig. 4f shows the *J*-*V* characteristics of perovskite films without and with the g-C₃N₄QDs based on hole-only devices with a structure of FTO/PEDOT:PSS/Cs_{0.05}FA_{0.92}MA_{0.03}PbI_{2.91}Br_{0.09}/Spiro-OMe-TAD/MoO₃/Ag. The hole-only devices were tested under the dark condition different from the optimized photovoltaic devices. The electron and hole mobilities (μ) can be calculate according to Mott-Gurney's equation as follows. Where the values of ϵ_0 (the vacuum permittivity) and ϵ_r (material dielectric constant) are 8.8542×10^{-14} F cm⁻¹ and 6.5, respectively, μ is the electron/hole mobility and *L* is the perovskite layer thickness. Comparing to the control one, the hole mobility enhanced obviously by doping of g-C₃N₄QDs. The hole mobilities of devices based on perovskite and perovskite with g-C₃N₄QDs films are calculated by the equation, which are 7.23×10^{-3} and 9.48×10^{-3} cm² V⁻¹ S⁻¹ of perovskite with g-C₃N₄QDs film, respectively.

High-quality crystal in the perovskite films is key to carriers transmission between each layer in good ohmic contact, as previously mentioned, which allows for a more smooth of intermolecular charge transfer and hence a higher charge carrier mobility. The results are accord well with the time-resolved photoluminescence (TRPL) spectra (Fig. S2†). Which shows comparison of with and without the g-C₃N₄QDs films deposited on the electron-transporting layer. The PL decay spectra were fitted into a biexponential decay function consisting of two times intervals, corresponding to a fast and a slow decay process. The fast decay process is associated with the quenching of free carriers in the perovskite domain through the charge transfer to the HTL, and the slow decay process is related to the radiative decay. The fast decay time indicating a charge-transfer dominant decay mechanism. Fig. S3† shows Hall effect measurement dependence of carrier density and Hall mobility of perovskite film. The higher carrier density of perovskite-g-C₃N₄QDs film benefits from the compact and flat surface. In addition, the Hall mobility in the perovskite-g-C₃N₄QDs film compared with the pristine perovskite film exhibits a larger value. This means that g-C₃N₄QDs doped perovskite film possess good conductivity, which enables corresponding PSCs to have a better device performance.

Conclusion

In summary, we demonstrated the effect of g-C₃N₄QDs on the performance of PSCs and investigated the action mechanism of the morphology, carrier mobility and interface electrical characteristic of perovskite film. The PCE of g-C₃N₄QDs based PSCs

demonstrated a power conversion efficiency as high as 20.02% with simultaneous improvements of *J*_{sc} (23.95 to 25.93 mA cm⁻²) and FF (0.74 to 0.78). The improved performance of PSCs benefits from high carrier mobility and reduced defects of perovskite film. The larger grains and uniform morphology of perovskite film also reduced series resistance and charge recombination chance.

Conflicts of interest

There are no conflicts to declare.

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